Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	er
09/877,622	LIU ET AL.	
Examiner	Art Unit	
Jennifer T. Nauven	2674	

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	SEARCHED				
Class	Subclass	Date	Examiner		
345	173	7/7/05	JN		
	174				
	177				
	179				
178	18.61-				
	18.07				

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Class	Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East search	7/7/05	JN	